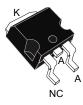


## 1200 V, 20 A, silicon carbide power Schottky diode





D<sup>2</sup>PAK HV

#### Product label



#### Product status link

STPSC20H12G2-TR

| Product summary         |        |  |  |  |
|-------------------------|--------|--|--|--|
| I <sub>F(AV)</sub> 20 A |        |  |  |  |
| V <sub>RRM</sub>        | 1200 V |  |  |  |
| T <sub>j</sub> (max.)   | 175 °C |  |  |  |
| V <sub>F</sub> (typ.)   | 1.35 V |  |  |  |

#### **Features**

- · No or negligible reverse recovery
- · Switching behavior independent of temperature
- · Robust high voltage periphery
- Operating T<sub>i</sub> from -40 °C to 175 °C
- Low V<sub>F</sub>
- D<sup>2</sup>PAK HV creepage distance (anode to cathode) = 5.38 mm min.
- ECOPACK2 compliant

#### **Applications**

- · EV Charging station
- DC/DC
- PFC

#### **Description**

This 20 A, 1200 V SiC diode is an ultra-high performance power Schottky diode. It is manufactured using a silicon carbide substrate. The wide band gap material allows the design of a Schottky diode structure with a 1200 V rating. Due to the Schottky construction, no recovery is shown at turn-off and ringing patterns are negligible. The minimal capacitive turn-off behavior is independent of temperature.

Housed in D<sup>2</sup>PAK HV, this diode is perfectly suited for a usage in PFC applications, in charging station, DC/DC, easing the compliance to IEC-60664-1.

The STPSC20H12G2-TR will boost performances in hard switching conditions. Its high forward surge capability ensures good robustness during transient phases.



## 1 Characteristics

Table 1. Absolute ratings (limiting values at 25 °C, unless otherwise specified)

| Symbol              | Paran  | Value  | Unit |   |  |
|---------------------|--|--|------|---|--|
| $V_{RRM}$           | Repetitive peak reverse voltage (T <sub>j</sub> = -40 °C to +175 °C) |  | 1200 | V |  |
| I <sub>F(RMS)</sub> | Forward rms current  |  | 38   | Α |  |
| I <sub>F(AV)</sub>  | Average forward current T <sub>c</sub> = 155 °C, DC current          |  | 20   | Α |  |
| I <sub>FRM</sub>    | Repetitive peak forward current                                      | $T_c = 155 ^{\circ}C, T_j = 175 ^{\circ}C, \delta = 0.1$   | 78   | Α |  |
|                     | Common and station for some of                                       | $t_p$ = 10 ms sinusoidal, $T_c$ = 25 °C                    | 140  | ^ |  |
| I <sub>FSM</sub>    | Surge non repetitive forward current                                 | t <sub>p</sub> = 10 ms sinusoidal, T <sub>c</sub> = 150 °C | 120  | Α |  |
| T <sub>stg</sub>    | Storage temperature range  | -65 to +175  | °C   |   |  |
| Tj                  | Operating junction temperature <sup>(1)</sup>                        | perating junction temperature <sup>(1)</sup>               |      |   |  |

<sup>1.</sup>  $(dP_{tot}/dT_j) < (1/R_{th(j-a)})$  condition to avoid thermal runaway for a diode on its own heatsink.

Table 2. Thermal resistance parameters

| Symbol               | Parameter        | Value |      |       |  | Unit |
|----------------------|------------------|-------|------|-------|--|------|
|                      | Farameter        | Тур.  | Max. | Oille |  |      |
| R <sub>th(j-c)</sub> | Junction to case | 0.30  | 0.45 | °C/W  |  |      |

Table 3. Static electrical characteristics

| Symbol                        | Parameter                | Test conditions         |                       | Min. | Тур. | Max. | Unit |
|-------------------------------|--------------------------|-------------------------|-----------------------|------|------|------|------|
| I <sub>R</sub> <sup>(1)</sup> | Povorno logizado gurrent | T <sub>j</sub> = 25 °C  | $V_R = V_{RRM}$       | -    | 10   | 120  | μA   |
|                               | Reverse leakage current  | T <sub>j</sub> = 150 °C |                       | -    | 60   | 800  |      |
| V <sub>F</sub> <sup>(2)</sup> | Forward voltage drap     | T <sub>j</sub> = 25 °C  | I <sub>F</sub> = 20 A | -    | 1.35 | 1.50 | V    |
|                               | Forward voltage drop     | T <sub>j</sub> = 150 °C |                       | -    | 1.75 | 2.25 |      |

<sup>1.</sup> Pulse test:  $t_p = 5$  ms,  $\delta < 2\%$ 

To evaluate the conduction losses, use the following equation:

•  $P = 1.07 \times I_{F(AV)} + 0.059 \times I_{F^{2}(RMS)}$ 

For more information, please refer to the following application notes related to the power losses:

- AN604: Calculation of conduction losses in a power rectifier
- AN4021: Calculation of reverse losses on a power diode

DS13410 - Rev 1 page 2/11

<sup>2.</sup> Pulse test:  $t_p$  = 500  $\mu$ s,  $\delta$  < 2%



**Table 4. Dynamic electrical characteristics** 

| Symbol              | Parameter               | Test conditions   | Min. | Тур. | Max. | Unit |
|---------------------|-------------------------|---|------|------|------|------|
| Q <sub>Cj</sub> (1) | Total capacitive charge | V <sub>R</sub> = 800 V                                    | -    | 129  | -    | nC   |
| C <sub>j</sub>      | Total capacitance       | V <sub>R</sub> = 0 V, T <sub>c</sub> = 25 °C, F = 1 MHz   | -    | 1650 | -    | pF   |
|                     | Total capacitance       | V <sub>R</sub> = 800 V, T <sub>c</sub> = 25 °C, F = 1 MHz | -    | 110  | -    | þΓ   |

1. Most accurate value for the capacitive charge:  $Q_{Cj}(V_R) = \int\limits_0^{V_R} C_j(V) dV$ 

DS13410 - Rev 1 page 3/11



#### 1.1 Characteristics (curves)

Figure 1. Forward voltage drop versus forward current (typical values)

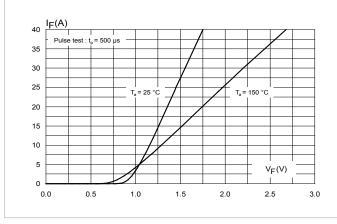


Figure 2. Reverse leakage current versus reverse voltage applied (typical values)

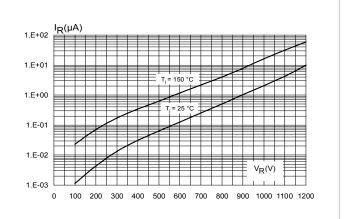


Figure 3. Peak forward current versus case temperature

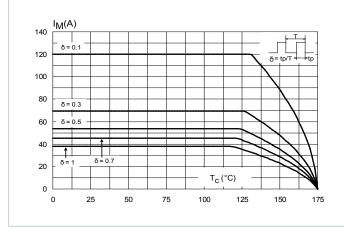


Figure 4. Junction capacitance versus reverse voltage applied (typical values)

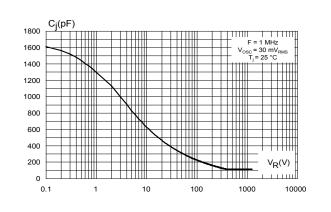


Figure 5. Relative variation of thermal impedance junction to case versus pulse duration

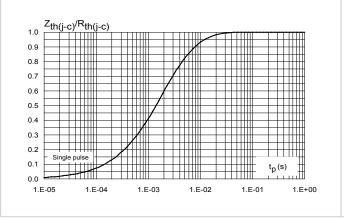
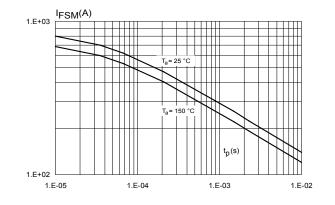


Figure 6. Non- repetitive peak surge forward current versus pulse duration (sinusoidal waveform)



DS13410 - Rev 1 page 4/11



Figure 7. Total capacitive charges versus reverse voltage applied (typical values)

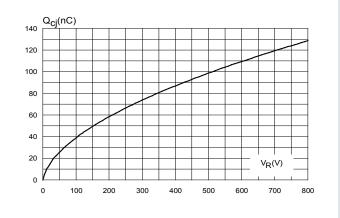
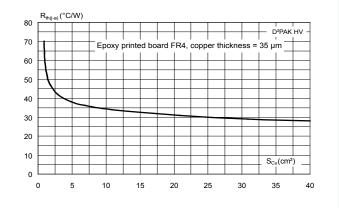


Figure 8. Thermal resistance junction to ambient versus copper surface under tab for D<sup>2</sup>PAK package (typical values)



DS13410 - Rev 1 page 5/11



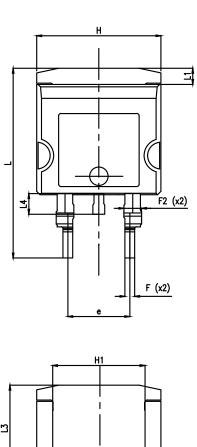
# 2 Package information

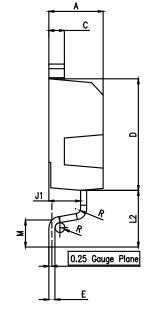
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

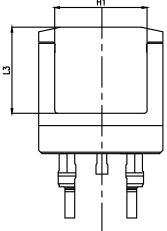
## 2.1 D<sup>2</sup>PAK high voltage package information

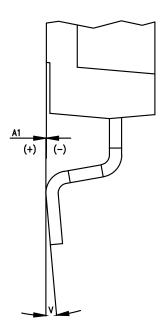
Epoxy meets UL94, V0

Figure 9. D<sup>2</sup>PAK high voltage package outline









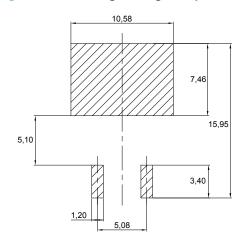
DS13410 - Rev 1 page 6/11



Table 5. D<sup>2</sup>PAK high voltage package mechanical data

| D-f  |       | Dimensions |       |
|------|-------|------------|-------|
| Ref. | Min.  | Тур.       | Max.  |
| А    | 4.30  | -          | 4.70  |
| A1   | 0.03  | -          | 0.20  |
| С    | 1.17  | -          | 1.37  |
| D    | 8.95  | -          | 9.35  |
| е    | 4.98  | -          | 5.18  |
| Е    | 0.50  | -          | 0.90  |
| F    | 0.78  | -          | 0.85  |
| F2   | 1.14  | -          | 1.70  |
| Н    | 10.00 | -          | 10.40 |
| H1   | 7.40  | -          | 7.80  |
| J1   | 2.49  | -          | 2.69  |
| L    | 15.30 | -          | 15.80 |
| L1   | 1.27  | -          | 1.40  |
| L2   | 4.93  | -          | 5.23  |
| L3   | 6.85  | -          | 7.25  |
| L4   | 1.5   | -          | 1.7   |
| M    | 2.6   | -          | 2.9   |
| R    | 0.20  | -          | 0.60  |
| V    | 0°    | -          | 8°    |

Figure 10. D<sup>2</sup>PAK high voltage footprint in mm



DS13410 - Rev 1 page 7/11



#### 2.1.1 Creepage distance between Anode and Cathode

Table 6. Creepage distance between anode and cathode

| Symbol             | Parameter  |  |      |    |
|--------------------|--|--|------|----|
| Cd <sub>A-K1</sub> | Minimum creepage distance between A and K1 (with top coating)    |  | 5.38 | mm |
| Cd <sub>A-K2</sub> | 1inimum creepage distance between A and K2 (without top coating) |  | 3.48 | mm |

Note: D<sup>2</sup>PAK HV creepage distance (anode to cathode) = 5.38 mm min. (refer to IEC 60664-1)

Figure 11. Creepage with top coating

Creepage A

Minimum distance between A & K1 = 5.38 mm (with top coating)

Figure 12. Creepage without top coating

Creepage

K2

Minimum distance between A & K2 = 3.48 mm (without top coating)

DS13410 - Rev 1 page 8/11





# **3** Ordering information

**Table 7. Ordering information** 

| Order code      | Marking   | Package               | Weight | Base qty. | Delivery mode |
|-----------------|-----------|-----------------------|--------|-----------|---------------|
| STPSC20H12G2-TR | SC20H12G2 | D <sup>2</sup> PAK HV | 1.48 g | 1000      | Tape and reel |

DS13410 - Rev 1 page 9/11



# **Revision history**

**Table 8. Document revision history** 

| Date        | Revision | Changes      |
|-------------|----------|--------------|
| 31-Aug-2020 | 1        | First issue. |

DS13410 - Rev 1 page 10/11



#### **IMPORTANT NOTICE - PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, please refer to www.st.com/trademarks. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2020 STMicroelectronics - All rights reserved

DS13410 - Rev 1 page 11/11